

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/620,244	SCHUSTER ET AL.	
		Examiner	Art Unit	Page 1 of 3
		Lewis G. West	2682	

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		Examiner Lewis G. West	Art Unit 2682	Page 2 of 3

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Examiner		Art Unit		Page 3 of 3
Lewis G. West		2682		

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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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